

## Supplementary Material

### High piezoelectricity of $\text{Eu}^{3+}$ -doped $\text{Pb}(\text{Mg}_{1/3}\text{Nb}_{2/3})\text{O}_3$ -0.25 $\text{PbTiO}_3$ transparent ceramics

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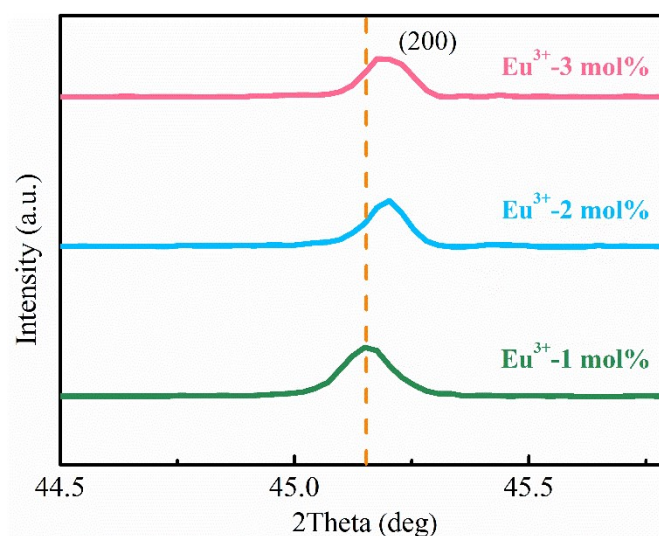


Fig. S1. The enlarged XRD patterns of  $\text{Eu}^{3+}$  doped PMN-PT transparent ceramics with the  $2\theta$  ranging from  $44.5^\circ$  to  $45.8^\circ$ .

The Vogel-Fulcher (V-F) relation is given by<sup>1,2</sup>:

$$f = f_0 \exp\left[\frac{-E_a}{k(T_m - T_f)}\right] \quad (\text{S1})$$

where  $f_0$ ,  $f$ ,  $T_m$  and  $k$  are the Debye frequency, measurement frequency, temperature corresponding to the maximum dielectric constant, and the Boltzmann constant. The  $E_a$  and  $T_f$  are the activation energy of local polarization and static freezing temperature of the thermal activation behavior of electric dipoles, i.e., the transition temperature between macro-domain and micro-domain structures. For relaxor ferroelectrics, when the temperature is above  $T_f$ , macro-domains disappear while polar nanoregions develop. When temperature is below  $T_f$  the polar nanoregion dynamics will be frozen and the system will be in the low-temperature ferroelectric (FE) phase. In PMN-0.25PT:Eu<sup>3+</sup> ceramics, the relationship between  $T_m$  and  $f$  was fitted by Eq. (S1), as seen in Fig. S2 (a)-(c). The corresponding parameters are obtained and listed in Table S1.

In addition, the dielectric quadratic relation is suggested as follows<sup>3</sup>:

$$\frac{\varepsilon_A}{\varepsilon} - 1 = \frac{(T - T_A)^2}{2\delta^2} \quad (\text{S2})$$

where the value of the fitting  $\delta$  parameter represents the diffuse degree of phase transition. Fig. S2(d)-(f) illustrate the temperature and frequency dependence of dielectric permittivity and the fitting using Eq. (S2) for PMN-0.25PT:Eu<sup>3+</sup> ceramics. Obviously, the experimental data were fitted well and the parameters were listed in Table S1. Furthermore, the  $\Delta T_m$  ( $\Delta T_m = T_m$  (100 kHz) -  $T_m$  (100 Hz)) was also

calculated and listed in Table S1. We can see that the degree of dielectric relaxation is stronger for higher  $\text{Eu}^{3+}$  doping amount.

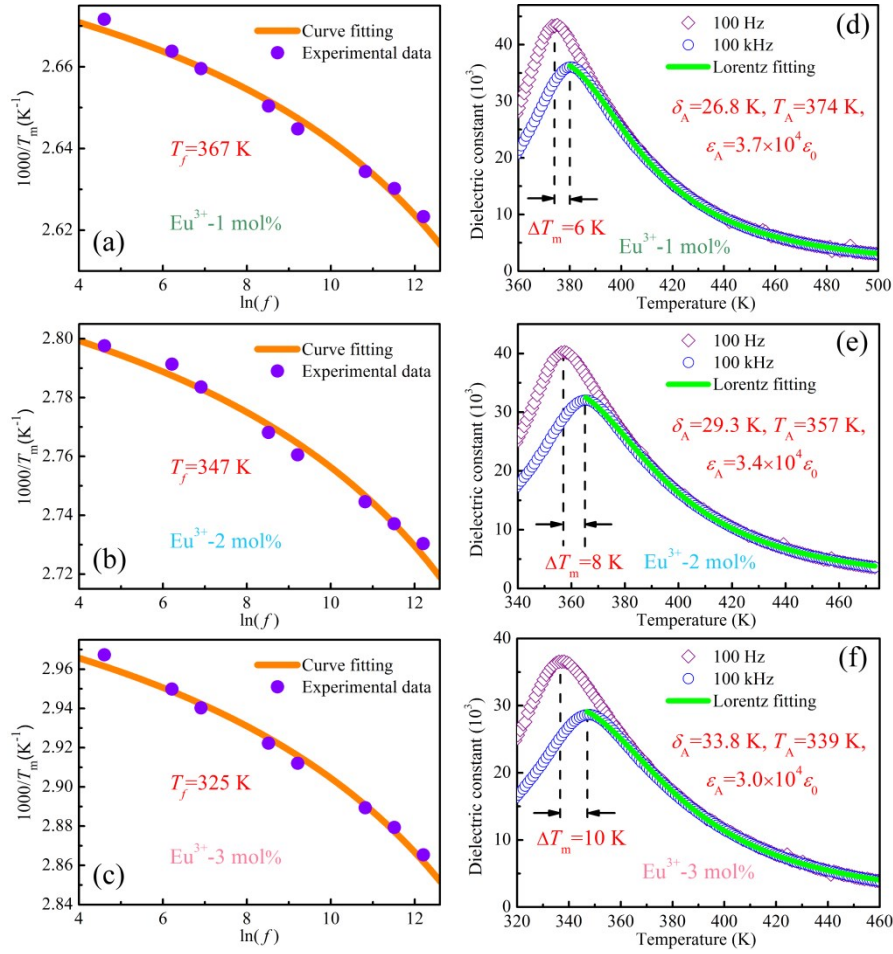


Fig. S2. The Vogel-Fulcher law and Lorentz-type relation fitting results for PMN-0.25PT:Eu<sup>3+</sup> ceramics, (a), (d) 1 mol% Eu<sup>3+</sup>, (b), (e) 2 mol% Eu<sup>3+</sup> and (c), (f) 3 mol% Eu<sup>3+</sup>.

**Table S1** The values of  $\Delta T_m$  and fitting parameters for Eu<sup>3+</sup>-doped PMN-0.25PT ceramics.

Eu <sup>3+</sup> (mol%)	$f_0$ (10 <sup>5</sup> kHz)	$E_a/k$ (K)	$T_f$ (K)	$\Delta T_m$ (K)	$\delta$ (K)	$T_A$ (K)	$\epsilon_A$ (10 <sup>3</sup> $\epsilon_0$ )
1	9.6	122	367	6	26.8	374	37
2	9.8	166	347	8	29.3	357	34
3	10	212	325	10	33.8	339	30

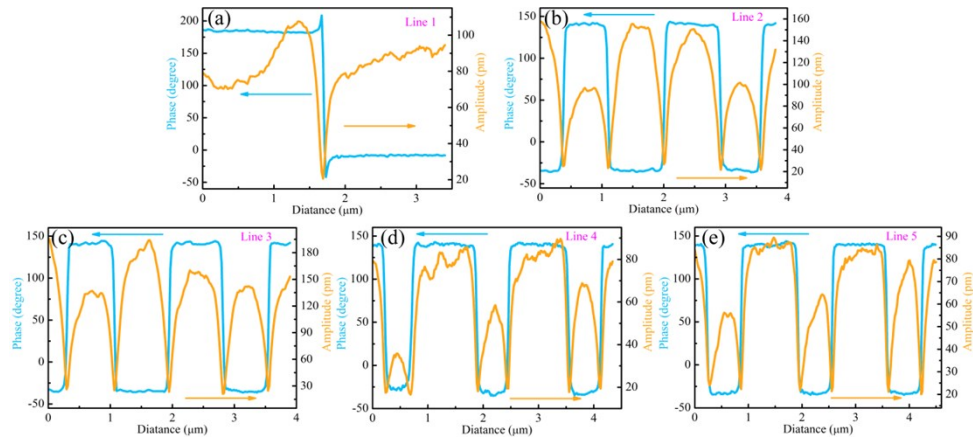


Fig. S3. The piezoresponse amplitude and phase degree of the line scanning across the domain patterns of 2mol%  $\text{Eu}^{3+}$ -doped PMN-0.25PT transparent ceramics.

The piezoelectric coefficients ( $d_{33}$ ) of various transparent ferroelectric ceramics shown in Fig.4 were taken from ref. 4-18.

## References

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